

TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

# TC74VHC393F, TC74VHC393FN, TC74VHC393FT

## DUAL BINARY COUNTER

(Note) The JEDEC SOP (FN) is not available in Japan.

The TC74VHC393 is an advanced high speed CMOS 4-BIT BINARY COUNTER fabricated with silicon gate C<sup>2</sup>MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

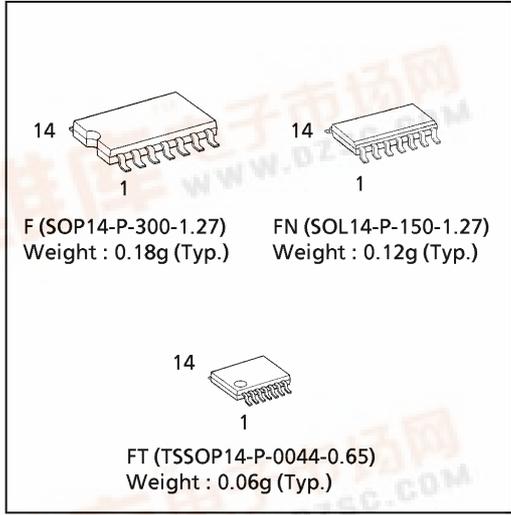
It contains two independent counter circuits in one package, so that counting or frequency division of eight binary bits can be achieved with one IC.

This device changes state on the negative going transition of the  $\overline{\text{CLOCK}}$  pulse. The counter can be reset to "0" ( $Q_0 \sim Q_3 = "L"$ ) by a high at the CLEAR input regardless of other inputs.

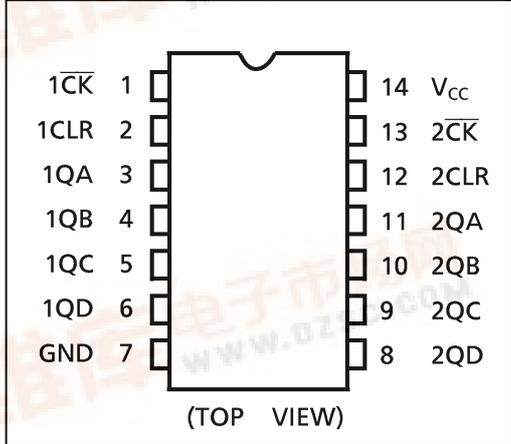
An input protection circuit ensures that 0 to 7V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5V to 3V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

### FEATURES:

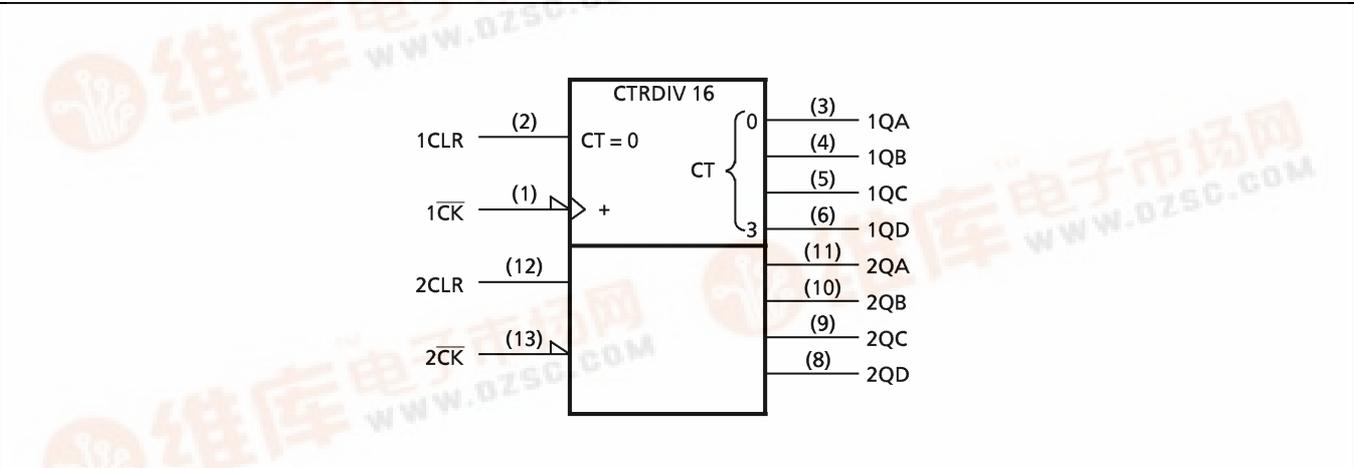
- High Speed.....  $f_{\text{MAX}} = 170\text{MHz}(\text{typ.})$   
at  $V_{\text{CC}} = 5\text{V}$
- Low Power Dissipation.....  $I_{\text{CC}} = 4\mu\text{A}(\text{Max.})$  at  $T_a = 25^\circ\text{C}$
- High Noise Immunity.....  $V_{\text{NIH}} = V_{\text{NIL}} = 28\% V_{\text{CC}} (\text{Min.})$
- Power Down Protection is provided on all inputs.
- Balanced Propagation Delays.....  $t_{\text{PLH}} \approx t_{\text{PHL}}$
- Wide Operating Voltage Range.....  $V_{\text{CC}} (\text{opr}) = 2\text{V} \sim 5.5\text{V}$
- Low Noise.....  $V_{\text{OLP}} = 0.8\text{V} (\text{Max.})$
- Pin and Function Compatible with 74ALS393



### PIN ASSIGNMENT



### IEC LOGIC SYMBOL



961001EBA2

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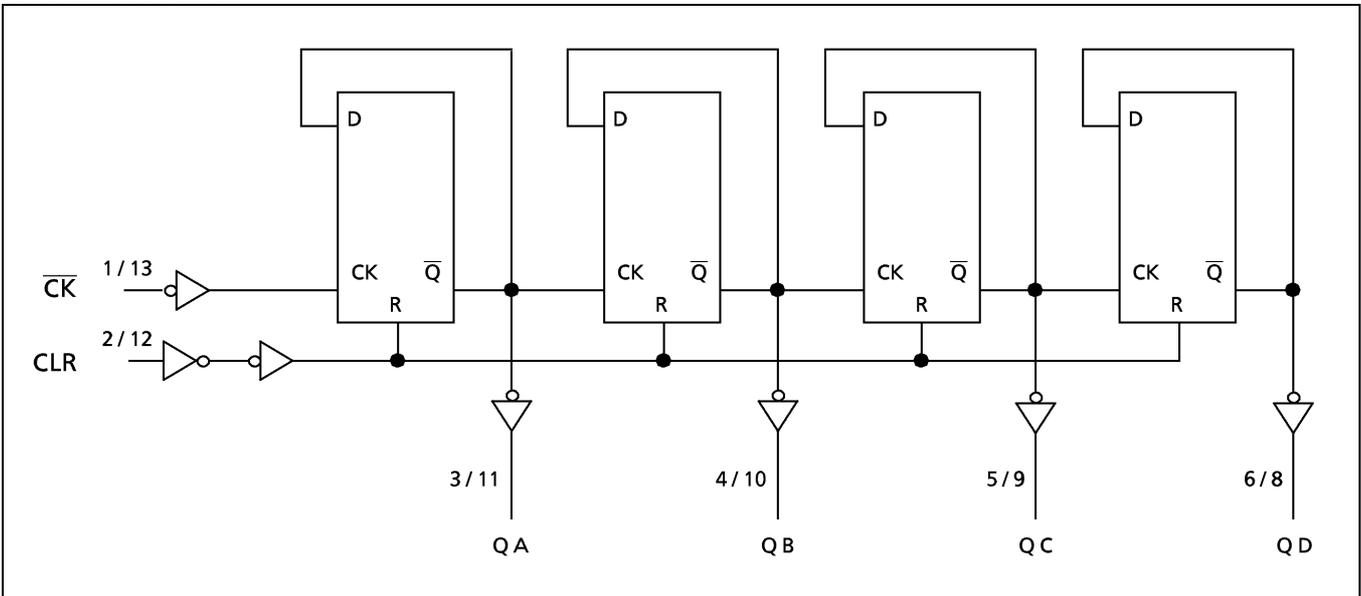


**TRUTH TABLE**

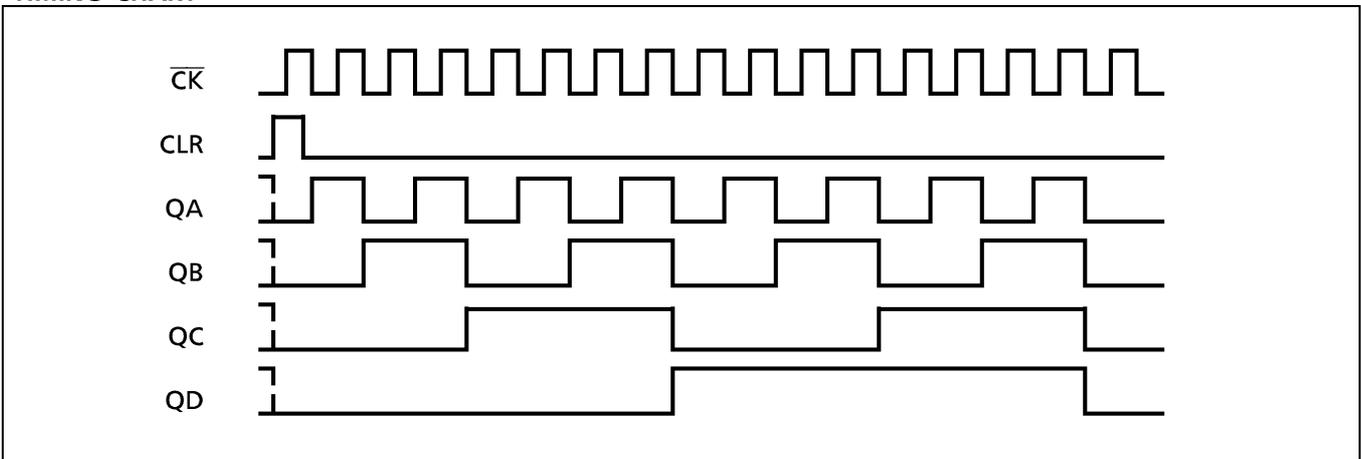
INPUTS		OUTPUTS			
$\overline{CK}$	CLR	QA	QB	QC	QD
X	H	L	L	L	L
	L	COUNT UP			
	L	NO CHANGE			

X : Don't Care

**SYSTEM DIAGRAM**



**TIMING CHART**



961001EBA2'

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## ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	$V_{CC}$	-0.5~7.0	V
DC Input Voltage	$V_{IN}$	-0.5~7.0	V
DC Output Voltage	$V_{OUT}$	-0.5~ $V_{CC} + 0.5$	V
Input Diode Current	$I_{IK}$	-20	mA
Output Diode Current	$I_{OK}$	$\pm 20$	mA
DC Output Current	$I_{OUT}$	$\pm 25$	mA
DC $V_{CC}$ /Ground Current	$I_{CC}$	$\pm 75$	mA
Power Dissipation	$P_D$	180	mW
Storage Temperature	$T_{stg}$	-65~150	$^{\circ}C$

## RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	$V_{CC}$	2.0~5.5	V
Input Voltage	$V_{IN}$	0~5.5	V
Output Voltage	$V_{OUT}$	0~ $V_{CC}$	V
Operating Temperature	$T_{opr}$	-40~85	$^{\circ}C$
Input Rise and Fall Time	$dt/dv$	0~100 ( $V_{CC} = 3.3 \pm 0.3V$ ) 0~20 ( $V_{CC} = 5 \pm 0.5V$ )	ns/V

## DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION	$V_{CC}$ (V)	$T_a = 25^{\circ}C$			$T_a = -40 \sim 85^{\circ}C$		UNIT		
				MIN.	TYP.	MAX.	MIN.	MAX.			
High - Level Input Voltage	$V_{IH}$		2.0	1.50	—	—	1.50	—	V		
			3.0~5.5	$V_{CC} \times 0.7$	—	—	$V_{CC} \times 0.7$	—			
Low - Level Input Voltage	$V_{IL}$		2.0	—	—	0.50	—	0.50	V		
			3.0~5.5	—	—	$V_{CC} \times 0.3$	—	$V_{CC} \times 0.3$			
High - Level Output Voltage	$V_{OH}$	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OH} = -50 \mu A$	2.0	1.9	2.0	—	1.9	—	V	
				3.0	2.9	3.0	—	2.9	—		
			3.0	2.58	—	—	2.48	—	3.80		—
Low - Level Output Voltage	$V_{OL}$	$V_{IN} = V_{IH}$ or $V_{IL}$	$I_{OL} = 50 \mu A$	2.0	—	0.0	0.1	—	0.1	V	
				3.0	—	0.0	0.1	—	0.1		
			3.0	—	—	0.36	—	0.44	—		
											4.5
Input Leakage Current	$I_{IN}$	$V_{IN} = 5.5V$ or GND	0~5.5	—	—	$\pm 0.1$	—	$\pm 1.0$	$\mu A$		
Quiescent Supply Current	$I_{CC}$	$V_{IN} = V_{CC}$ or GND	5.5	—	—	4.0	—	40.0			

**TIMING REQUIREMENTS (Input  $t_r = t_f = 3ns$ )**

PARAMETER	SYMBOL	TEST CONDITION	Ta = 25°C			Ta = -40~85°C	UNIT
			V <sub>CC</sub> (V)	TYP.	LIMIT	LIMIT	
Minimum Pulse Width (CK)	t <sub>w(H)</sub> t <sub>w(L)</sub>		3.3 ± 0.3	—	5.0	5.0	ns
			5.0 ± 0.5	—	5.0	5.0	
Minimum Pulse Width (CLR)	t <sub>w(H)</sub>		3.3 ± 0.3	—	5.0	5.0	
			5.0 ± 0.5	—	5.0	5.0	
Minimum Removal Time	t <sub>rem</sub>		3.3 ± 0.3	—	5.0	5.0	
			5.0 ± 0.5	—	4.0	4.0	

**AC ELECTRICAL CHARACTERISTICS (Input  $t_r = t_f = 3ns$ )**

PARAMETER	SYMBOL	TEST CONDITION		Ta = 25°C			Ta = -40~85°C		UNIT
		V <sub>CC</sub> (V)	CL (pF)	MIN.	TYP.	MAX.	MIN.	MAX.	
Propagation Delay Time (CK - QA)	t <sub>pLH</sub> t <sub>pHL</sub>	3.3 ± 0.3	15	—	8.6	13.2	1.0	15.5	ns
			50	—	11.1	16.7	1.0	19.0	
		5.0 ± 0.5	15	—	5.8	8.5	1.0	10.0	
			50	—	7.3	10.5	1.0	12.0	
Propagation Delay Time (CK - QB)	t <sub>pLH</sub> t <sub>pHL</sub>	3.3 ± 0.3	15	—	10.2	15.8	1.0	18.5	
			50	—	12.7	19.3	1.0	22.0	
		5.0 ± 0.5	15	—	6.8	9.8	1.0	11.5	
			50	—	8.3	11.8	1.0	13.5	
Propagation Delay Time (CK - QC)	t <sub>pLH</sub> t <sub>pHL</sub>	3.3 ± 0.3	15	—	11.7	18.0	1.0	21.0	
			50	—	14.2	21.5	1.0	24.5	
		5.0 ± 0.5	15	—	7.7	11.2	1.0	13.0	
			50	—	9.2	13.2	1.0	15.0	
Propagation Delay Time (CK - QD)	t <sub>pLH</sub> t <sub>pHL</sub>	3.3 ± 0.3	15	—	13.0	19.7	1.0	23.0	
			50	—	15.5	23.2	1.0	26.5	
		5.0 ± 0.5	15	—	8.5	12.5	1.0	14.5	
			50	—	10.0	14.5	1.0	16.5	
Propagation Delay Time (CLR - Qn)	t <sub>pHL</sub>	3.3 ± 0.3	15	—	7.9	12.3	1.0	14.5	
			50	—	10.4	15.8	1.0	18.0	
		5.0 ± 0.5	15	—	5.4	8.1	1.0	9.5	
			50	—	6.9	10.1	1.0	11.5	
Maximum Clock Frequency	f <sub>MAX</sub>	3.3 ± 0.3	15	75	120	—	65	—	MHZ
			50	45	65	—	35	—	
		5.0 ± 0.5	15	125	170	—	105	—	
			50	85	115	—	75	—	
Input Capacitance	C <sub>IN</sub>			—	4	10	—	10	pF
Power Dissipation Capacitance	C <sub>PD</sub>	Note (1)		—	23	—	—	—	

Note (1) C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

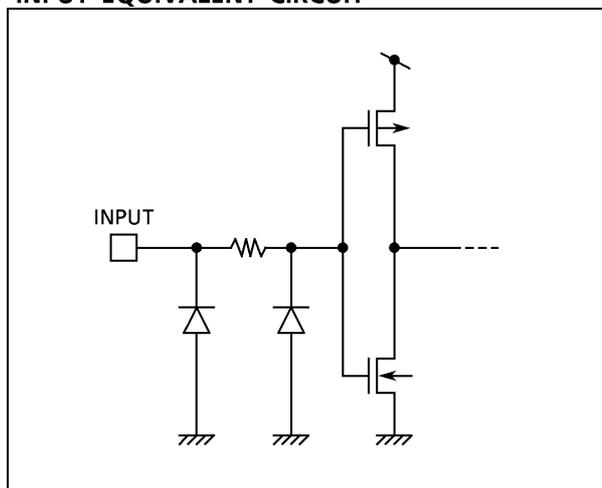
Average operating current can be obtained by the equation :

$$I_{CC(opr.)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/2 \text{ (per counter)}$$

**NOISE CHARACTERISTICS (Input  $t_r = t_f = 3ns$ )**

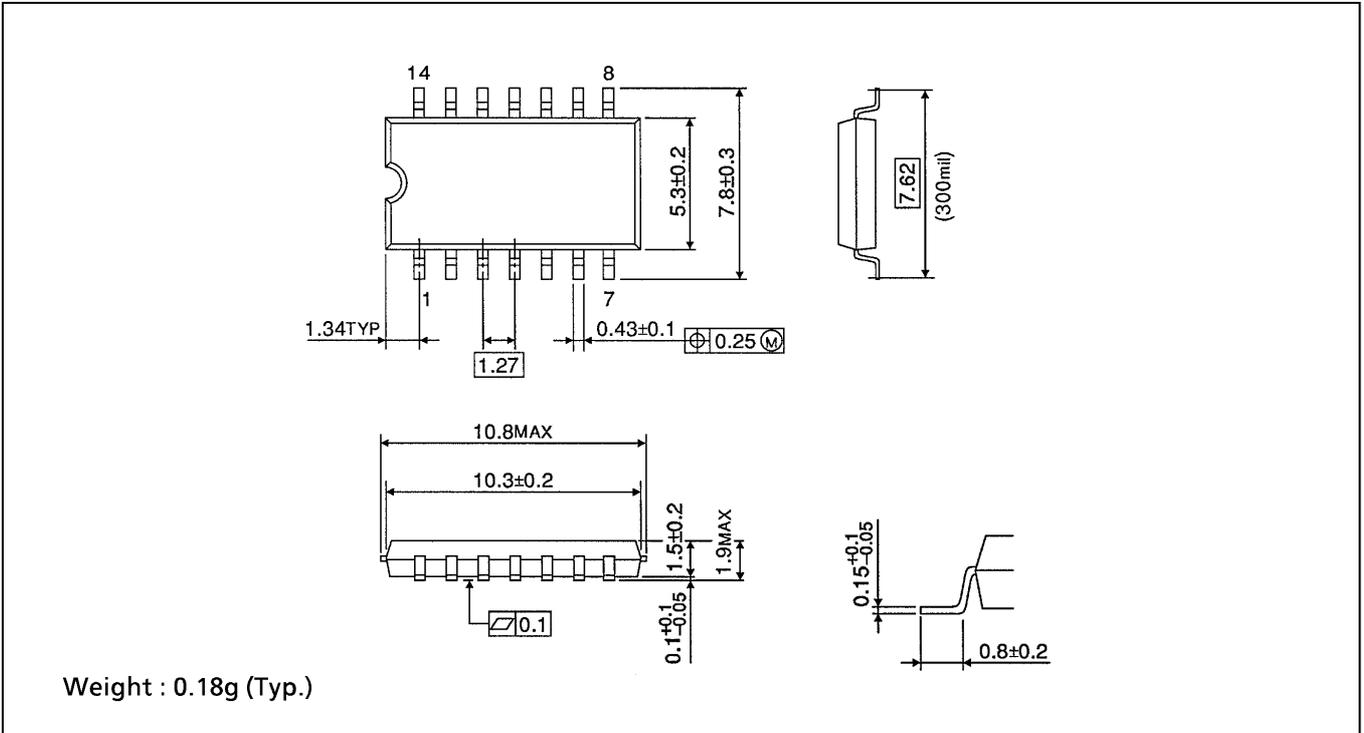
PARAMETER	SYMBOL	TEST CONDITION	Ta = 25°C		UNIT	
			V <sub>CC</sub> (V)	TYP.		MAX.
Quiet Output Maximum Dynamic V <sub>OL</sub>	V <sub>OLP</sub>	C <sub>L</sub> = 50pF	5.0	0.5	0.8	V
Quiet Output Minimum Dynamic V <sub>OL</sub>	V <sub>OLV</sub>	C <sub>L</sub> = 50pF	5.0	-0.5	-0.8	V
Minimum High Level Dynamic Input Voltage	V <sub>IHD</sub>	C <sub>L</sub> = 50pF	5.0	-	3.5	V
Maximum Low Level Dynamic Input Voltage	V <sub>ILD</sub>	C <sub>L</sub> = 50pF	5.0	-	1.5	V

**INPUT EQUIVALENT CIRCUIT**



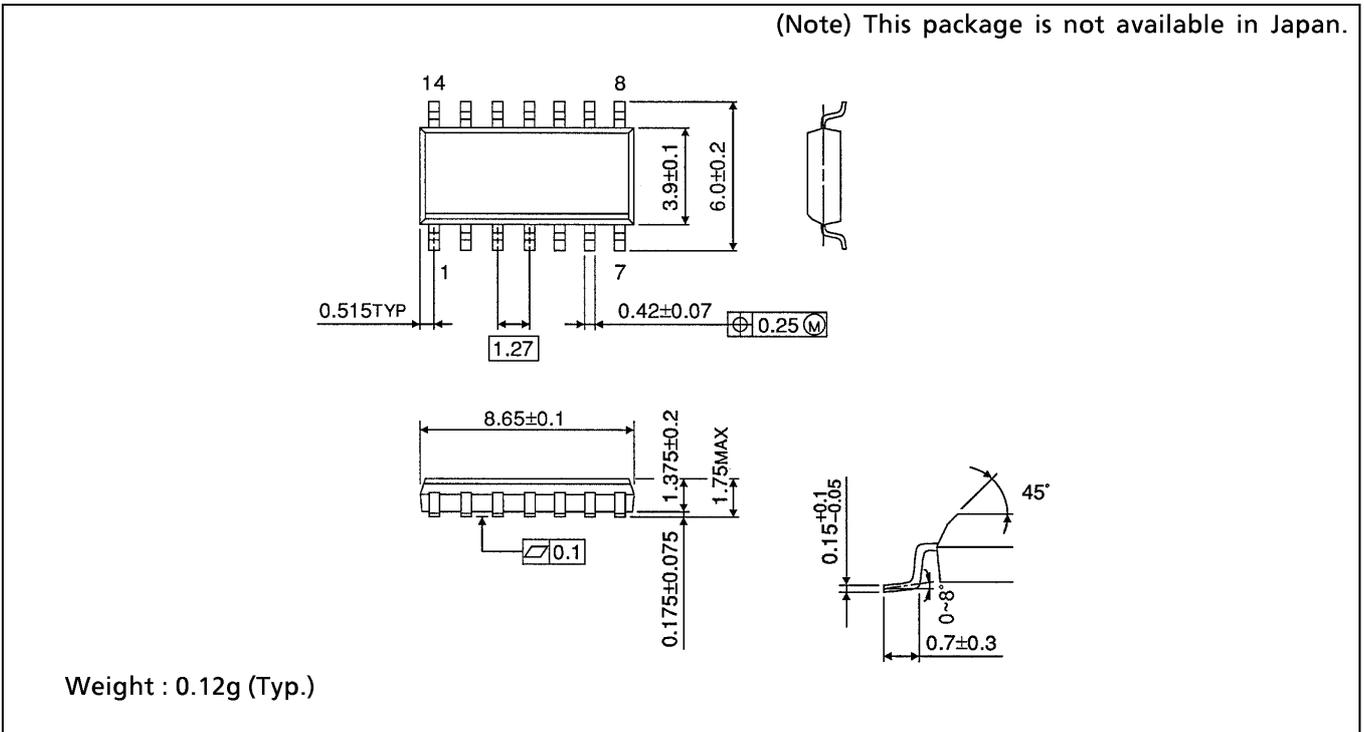
**SOP 14PIN (200mil BODY) OUTLINE DRAWING (SOP14-P-300-1.27)**

Unit in mm



**SOP 14PIN (150mil BODY) OUTLINE DRAWING (SOP14-P-150-1.27)**

Unit in mm



TSSOP 14PIN OUTLINE DRAWING (TSSOP14-P-0044-0.65)

Unit in mm

